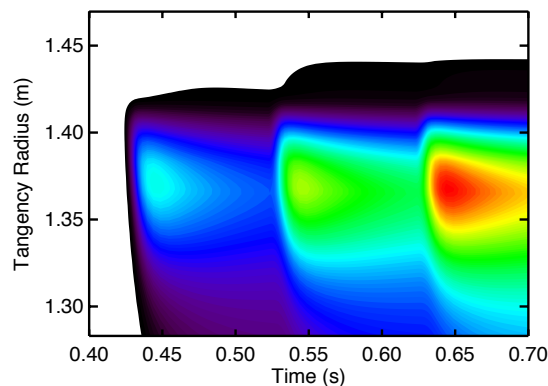


Direct Perturbative Transport Measurements with Proposed Diagnostics

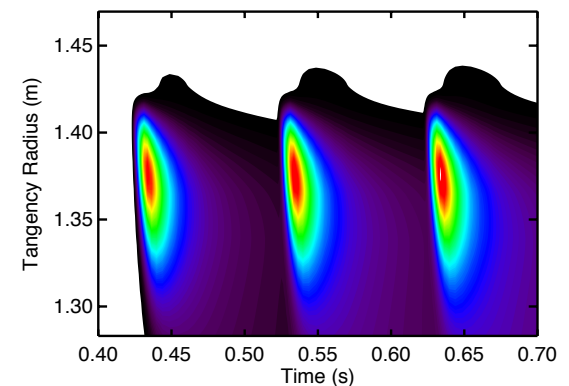
D. Clayton for the JHU Plasma Spectroscopy Group

- Laser ablation provides a well-defined, non-recycling impurity source
 - Better-constrained impurity source provides more accurate transport measurements
 - Short (1-2 ms) pulses of fast (a few eV) neutral atoms ($\sim 10^{17}$ particles per pulse, variable)
 - Injected source is monitored by a filtered diode
 - Impurities are non-recycling, removing additional source terms from model (Fourier technique)
 - Wider variety of impurities to choose from (C, Mo, non-intrinsic materials)
 - Multiple transport measurements per discharge (less impurity accumulation)
 - Laser ablation can also provide cold pulses for perturbative electron thermal transport
- New ME-SXR arrays will cover the core as well as the edge plasma
 - Fast (~ 10 -100 kHz) emission measurements for impurity transport
 - Fast T_e measurements between Thomson pulses for heat transport
- Upgraded TGIS will provide faster time resolution (5-10 ms) impurity profiles
 - Assists ME-SXR temperature modeling

**ME-SXR Model:
Recycling
Impurity**



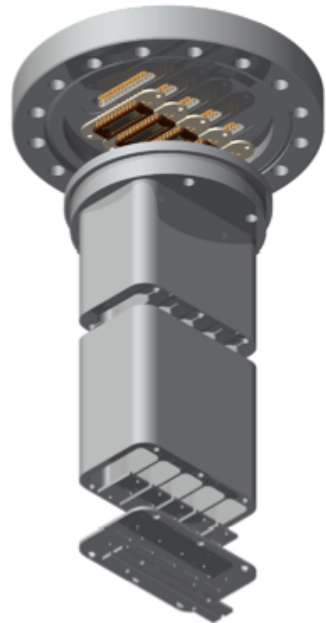
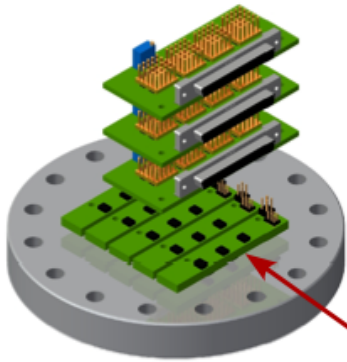
**ME-SXR Model:
Non-Recycling
Impurity**



Backup Slides

Toroidally Displaced In-vessel ME-SXR arrays

K. Tritz for the JHU Plasma Spectroscopy Group



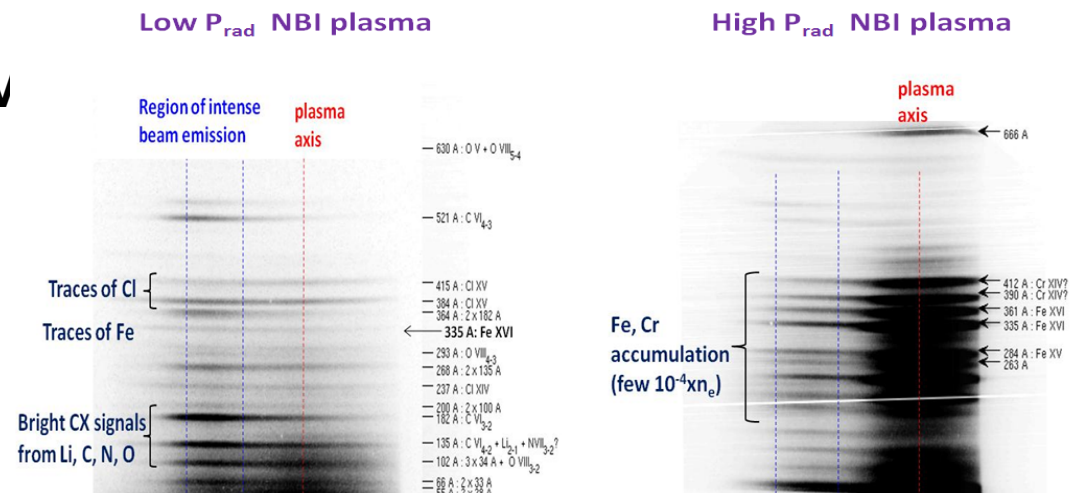
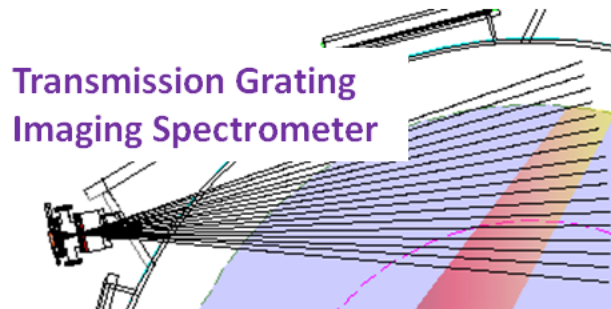
- **We propose a system of two toroidally displaced, tangential edge/core multi-energy SXR (ME-SXR) arrays**
- **Each array contains:**
 - edge sub-array ($130 < R < 150$) ~1cm resolution, 5 diode arrays @ 20ch. ea.
 - core sub-array ($40 < R < 140$) ~3cm resolution, 3 diode arrays @ 32ch ea.
 - time resolution 10-100kHz
- **In-vessel design reduces port crowding, increases placement flexibility**
 - design 1: electronics in re-entrant can @ atmosphere with air cooling
 - design 2: vacuum compatible first stage electronics on detector PCB
 - potential to incorporate A/D, (fiber?) serial output for reduced wire count
- **Projected physics capabilities for NSTX-U:**
 - impurity/electron perturbative transport measurements from the edge to the core using gas puff and repetitive laser blow-off
 - fast, high resolution edge T_e , n_e , and n_z profiles for ELM studies and code validation; edge stability analysis
 - fast, toroidally resolved edge T_e , n_e , and n_z profiles for RWM/RFA studies
 - fast, toroidally resolved core T_e , n_e , and n_z profiles for disruption studies
 - real-time T_e measurements for stability prediction and feedback control development
 - enhanced, non-magnetic MHD mode identification
- **Supports NSTX-U research priorities:**
 - I-1-4: macrostability research of RWMs, NTMs, effect of 3D fields, disruptions
 - II-3: impurity transport research (also pert. electron transport measurements)
 - III-3: measure response of edge plasma to applied 3D fields
 - VI-1,2: real-time T_e for stability feedback control, detection of instability precursors

Fast Transmission Grating Imaging Spectrometer (TGIS) for NSTX-U

D. Stutman for the Johns Hopkins Group

- **Fast tangential TGIS for space-resolved XUV (50-800 Å) impurity spectra:**
 - Space/time resolved impurity fractions for improved ME-SXR modeling
 - Low to high-Z impurity monitoring for start-up to non-inductive sustainment
 - Stand-alone' impurity transport (V pinch)
- **Parameters:**
 - ≥ 2 cm/5-10 ms space/time resolution, $90 \leq R \leq 150$ cm
 - Beam view for low-Z /CX , high-Z /electron-excited spectra
 - Enhanced Mo detection capability

• **Addresses II 2 III 2 V 1 2 V**

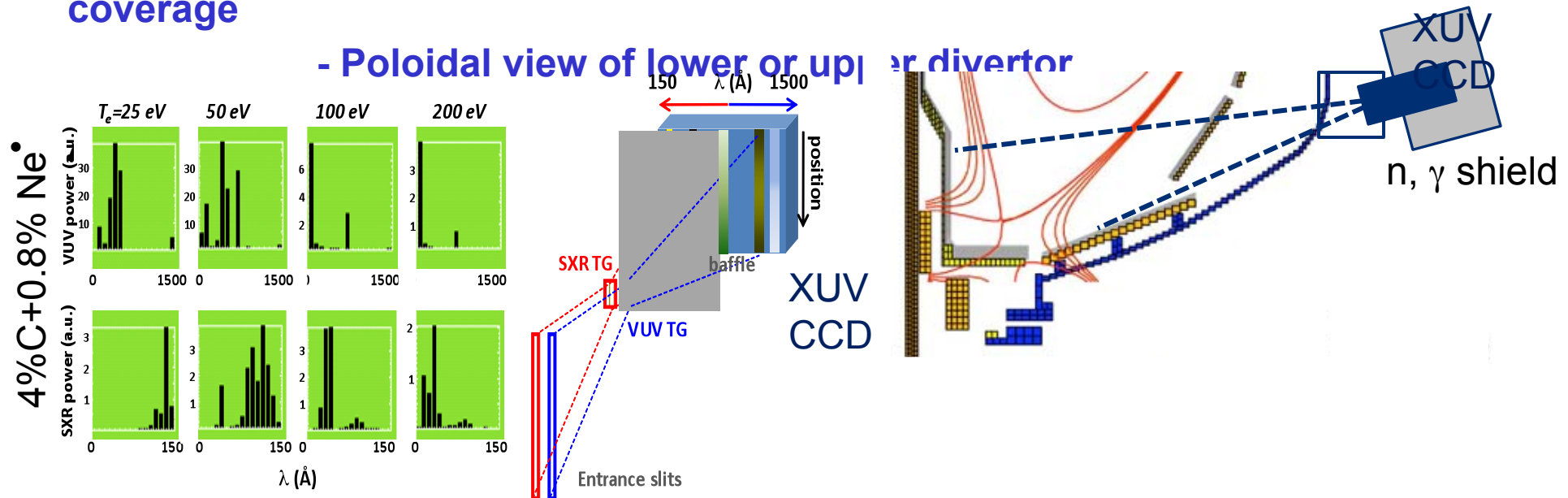


SXR/VUV Imaging Radiometer for NSTX-U divertor

D. Stutman for the Johns Hopkins Group

- Space/time resolved radiated power in $\lambda/\Delta\lambda \sim 1/20$ spectral bins covering the 0-150 Å ('SXR') and 0-1500 Å ('VUV) ranges
 - $P_{\text{rad}}(\lambda)$, impurity type, charge state distribution for enhanced constraints on divertor modeling (M. Jaworski)
 - Approximate line-of-sight T_e (with e.g., Neon seeding)
- Parameters:
 - Dual transmission grating + absolute XUV CCD for $P_{\text{rad}}(\lambda)$
 - ≥ 2 cm/5-10ms space/time resolution, strike to above X-point coverage

- Poloidal view of lower or upper divertor

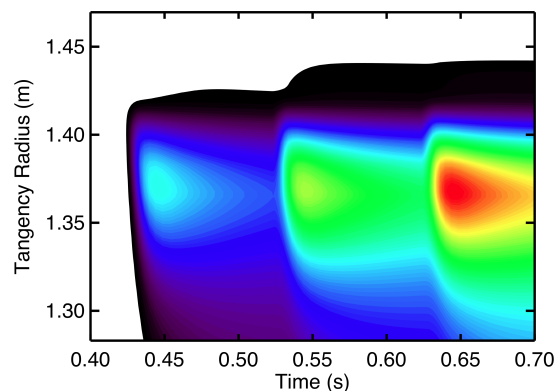


Repetitive Laser Blow-off Impurity Injection System

D. Clayton for the JHU Plasma Spectroscopy Group

- We propose a repetitive laser blow-off impurity injection system for transport measurements of non-recycling impurities
 - Laser with ≥ 10 Hz rep rate, 100's of mJ per pulse, scans target throughout discharge
 - Based on C-Mod system, cost within scope of a university collaboration
 - Impurity transport measurements will be made with JHU's proposed in-vessel ME-SXR arrays and fast TGIS diagnostics
 - Other possible uses include T_e transport measurements via cold pulse propagation
- Benefits of laser ablation of non-recycling impurities include:
 - More NSTX-relevant impurities (Li, C, Mo, etc.)
 - Better-constrained impurity source term for transport modeling
 - Multiple transport measurements per discharge (less impurity accumulation)
- Reflex discharge plasma will be used to characterize impurity injection
 - Simulate SOL conditions to determine source term and test STRAHL SOL model

ME-SXR Model:
Recycling
Impurity



ME-SXR Model:
Non-Recycling
Impurity

